

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE)  
CB SCHEME

## CB TEST CERTIFICATE

Product

1) Intel® NUC Pro Board Element (Main board)  
2) Intel® NUC Pro Compute Element (CPU board)

Name and address of the applicant

INTEL CORPORATION  
2200 MISSION COLLEGE BLVD SANTA CLARA, CA  
95054-1537 USA

Name and address of the manufacturer

INTEL CORPORATION  
2200 MISSION COLLEGE BLVD SANTA CLARA, CA  
95054-1537 USA

Name and address of the factory

Note: When more than one factory, please report on page 2

GOLDEN ELITE TECHNOLOGY (SHEN ZHEN) LTD  
1 NAN HUAN RD SHAJING BAO AN SHENZHEN GUANGDONG  
518104  
CHINA Additional Information on page 2

Ratings and principal characteristics

Electrical ratings not required  
(the equipment intended for building-in, supplied by SELV)

Trademark / Brand (if any)



Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

1) xCMB1ABx, xCMx1BBx  
2) xCM8xCBx  
See Page 2

Additional information (if necessary may also be reported on page 2)

 Additional Information on page 2

A sample of the product was tested and found to be in conformity with

IEC 60950-1:2005/AMD1:2009, IEC 60950-1:2005/AMD2:2013,  
IEC 60950-1:2005

As shown in the Test Report Ref. No. which forms part of this Certificate

ATTCB108134 issued on 2019-10-18

This CB Test Certificate is issued by the National Certification Body



- UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see [www.ul.com/ncbnames](http://www.ul.com/ncbnames)

Date: 2019-10-18

Signature:

Jan-Erik Storgaard



Ref. Certif. No.

**DK-88674-UL**

**Model Details:**

xCM8xCBx, xCMB1ABx, xCMx1BBx

(where x can be a combination of alphanumeric characters, none or blank)

**Additional Information:**

Additionally evaluated to EN 60950-1:2006 /A11:2009 /A1:2010 /A12:2011/ A2:2013.

National Difference specified in the CB Test Report

**Additional information (if necessary)**



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